## Notice of References Cited Application/Control No. 10/633,287 Examiner ANTHONY BANTAMOI Applicant(s)/Patent Under Reexamination YAMANE, KENJI Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0044732	03-2004	Fushiki et al.	709/205
*	В	US-7,271,809	09-2007	Fedorovskaya et al.	345/581
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-		+11	
	I	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0		_			
	Р		A			
	α					
9	R					
	s					
					100	

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.